

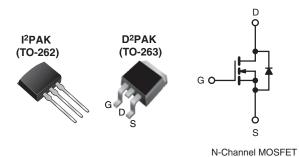
Vishay Siliconix

RoHS

COMPLIANT

### **Power MOSFET**

PRODUCT SUMMARY				
V <sub>DS</sub> (V)	500			
$R_{DS(on)}\left(\Omega\right)$	V <sub>GS</sub> = 10 V	0.85		
Q <sub>g</sub> (Max.) (nC)	39			
Q <sub>gs</sub> (nC)	10			
Q <sub>gd</sub> (nC)	19			
Configuration	Single			



#### **FEATURES**

- · Ultra Low Gate Charge
- · Reduced Gate Drive Requirement
- Enhanced 30 V V<sub>GS</sub> Rating
- Reduced C<sub>iss</sub>, C<sub>oss</sub>, C<sub>rss</sub>
- Extremely High Frequency Operation
- · Repetitive Avalanche Rated
- Lead (Pb)-free Available

#### **DESCRIPTION**

This new series of low charge Power MOSFETs achieve significantly lower gate charge then conventional Power MOSFETs. Utilizing the new LCDMOS (low charge device Power MOSFETs) technology, the device improvements are achieved without added product cost, allowing for reduced gate drive requirements and total system savings. In addition, reduced switching losses and improved efficiency are achievable in a variety of high frequency applications. Frequencies of a few MHz at high current are possible using the new low charge Power MOSFETs.

These device improvements combined with the proven ruggedness and reliability that characterize Power MOSFETs offer the designer a new power transistor standard for switching applications.

ORDERING INFORMATION				
Package	D <sup>2</sup> PAK (TO-263)	D <sup>2</sup> PAK (TO-263)	I <sup>2</sup> PAK (TO-262)	
Lead (Pb)-free	IRF840LCSPbF	-	IRF840LCLPbF	
Lead (PD)-liee	SiHF840LCS-E3	-	SiHF840LCL-E3	
SnPb	IRF840LCS	IRF840LCSTRR <sup>a</sup>	IRF840LCL	
SIPD	SiHF840LCS	SiHF840LCST <sup>a</sup>	SiHF840LCL	

#### Note

a. See device orientation.

PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-Source Voltage			$V_{DS}$	500	V	
Gate-Source Voltage			$V_{GS}$	± 30		
Continuous Drain Current	V <sub>GS</sub> at 10 V	T <sub>C</sub> = 25 °C	- I <sub>D</sub>	8.0	А	
Continuous Diain Current	VGS at 10 V	T <sub>C</sub> = 100 °C		5.1		
Pulsed Drain Current <sup>a, e</sup>			I <sub>DM</sub>	28		
Linear Derating Factor				1.0	W/°C	
Single Pulse Avalanche Energy <sup>b, e</sup>			E <sub>AS</sub>	510	mJ	
Avalanche Current <sup>a</sup>			I <sub>AR</sub>	8.0	Α	
Repetiitive Avalanche Energy <sup>a</sup>			E <sub>AR</sub>	13	mJ	
Maximum Power Dissipation	T <sub>C</sub> =	T <sub>C</sub> = 25 °C		3.1	W	
		T <sub>A</sub> = 25 °C		125		
Peak Diode Recovery dV/dtc, e	•		dV/dt	3.5	V/ns	
Operating Junction and Storage Temperature Range			T <sub>J</sub> , T <sub>stg</sub>	- 55 to + 150	°C	
Soldering Recommendations (Peak Temperature)	for	10 s		300 <sup>d</sup>	7	

#### **Notes**

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11). b. Starting T<sub>J</sub> = 25 °C, L = 14 mH, R<sub>G</sub> = 25  $\Omega$ , I<sub>AS</sub> = 8.0 A (see fig. 12). c. I<sub>SD</sub>  $\leq$  8.0 Å, dI/dt  $\leq$  100 A/µs, V<sub>DD</sub>  $\leq$  V<sub>DS</sub>, T<sub>J</sub>  $\leq$  150 °C.

- d. 1.6 mm from case.
- e. Uses IRF840LC/SiHF840LC data and test conditions.
- \* Pb containing terminations are not RoHS compliant, exemptions may apply

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THERMAL RESISTANCE RATINGS					
PARAMETER	SYMBOL	TYP.	MAX.	UNIT	
Maximum Junction-to-Ambient (PCB Mounted, steady-state) <sup>a</sup>	R <sub>thJA</sub>	-	40	°C/W	
Maximum Junction-to-Case (Drain)	R <sub>thJC</sub>	-	1.0		

#### Note

a. When mounted on 1" square PCB (FR-4 or G-10 material).

PARAMETER	SYMBOL	TEST CONDITIONS		MIN.	TYP.	MAX.	UNIT
Static						•	
Drain-Source Breakdown Voltage	V <sub>DS</sub>	V <sub>GS</sub> :	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		-	-	٧
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Referenc	Reference to 25 °C, I <sub>D</sub> = 1 mA <sup>c</sup>		0.63	-	V/°C
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	V <sub>DS</sub> =	$V_{DS} = V_{GS}, I_D = 250 \mu A$		-	4.0	٧
Gate-Source Leakage	I <sub>GSS</sub>	,	V <sub>GS</sub> = ± 20 V	-	-	± 100	nA
Zava Cata Valtaga Dvain Cuvvant	1	V <sub>DS</sub> =	V <sub>DS</sub> = 500 V, V <sub>GS</sub> = 0 V		-	25	μΑ
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> = 400 V	V <sub>DS</sub> = 400 V, V <sub>GS</sub> = 0 V, T <sub>J</sub> = 125 °C		-	250	
Drain-Source On-State Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V	I <sub>D</sub> = 4.8 A <sup>b</sup>	-	-	0.85	Ω
Forward Transconductance	9 <sub>fs</sub>	V <sub>DS</sub> = 50 V, I <sub>D</sub> = 4.8 A <sup>b</sup>		4.0	-	-	S
Dynamic		•					
Input Capacitance	C <sub>iss</sub>	$V_{GS} = 0 \text{ V},$ $V_{DS} = 25 \text{ V},$ f = 1.0 MHz, see fig. 5°		-	1100	-	pF
Output Capacitance	C <sub>oss</sub>			-	170	-	
Reverse Transfer Capacitance	C <sub>rss</sub>			-	18	-	
Total Gate Charge	Qg	$V_{GS} = 10 \text{ V}$ $I_D = 8.0 \text{ A}, V_{DS} = 400 \text{ V},$ see fig. 6 and 13 <sup>b, c</sup>		-	-	39	
Gate-Source Charge	Q <sub>gs</sub>		-	-	10	nC	
Gate-Drain Charge	$Q_{gd}$	See lig. 6 and 16		-	-		19
Turn-On Delay Time	t <sub>d(on)</sub>			-	12	-	
Rise Time	t <sub>r</sub>	$V_{DD}$ = 250 V, $I_D$ = 8.0 A, $R_G$ = 9.1 $\Omega$ , $R_D$ = 30 $\Omega$ , see fig. 10 <sup>b, c</sup>		-	25	-	ns
Turn-Off Delay Time	t <sub>d(off)</sub>			-	27	-	
Fall Time	t <sub>f</sub>			-	19	-	
Drain-Source Body Diode Characteristic	s						
Continuous Source-Drain Diode Current	Is	MOSFET sym showing the	MOSFET symbol showing the		-	8.0	A
Pulsed Diode Forward Current <sup>a</sup>	I <sub>SM</sub>	integral reverse p - n junction diode		-	-	28	
Body Diode Voltage	$V_{SD}$	$T_J = 25  ^{\circ}\text{C},  I_S = 8.0  \text{A},  V_{GS} = 0  \text{V}^{\text{b}}$		-	-	2.0	V
Body Diode Reverse Recovery Time	t <sub>rr</sub>	$T_J = 25  ^{\circ}\text{C},  I_F = 8.0  \text{A},  \text{dI/dt} = 100  \text{A/}\mu\text{s}^{\text{b, c}}$		-	490	740	ns
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>			-	3.0	4.5	μC
Forward Turn-On Time	t <sub>on</sub>	Intrinsic turn-on time is negligible (turn-on is dominated by L <sub>S</sub> and					

#### Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11). b. Pulse width  $\leq$  300  $\mu$ s; duty cycle  $\leq$  2 %. c. Uses SiHF840LC data and test conditions.

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#### TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

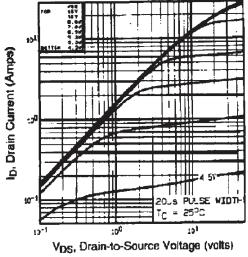


Fig. 1 - Typical Output Characteristics

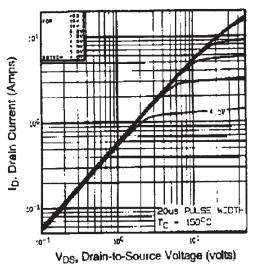


Fig. 2 - Typical Output Characteristics

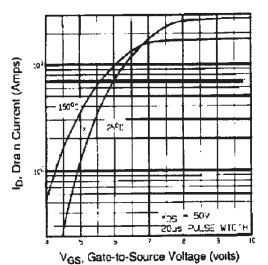


Fig. 3 - Typical Transfer Characteristics

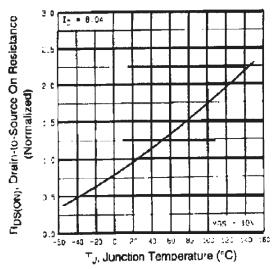


Fig. 4 - Normalized On-Resistance vs. Temperature

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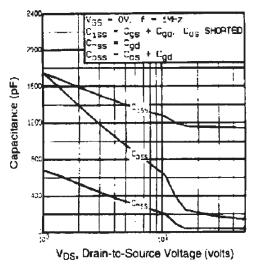


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

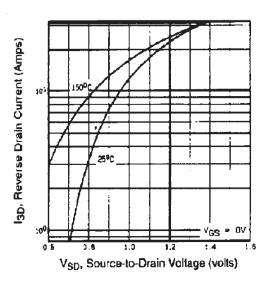


Fig. 7 - Typical Source-Drain Diode Forward Voltage

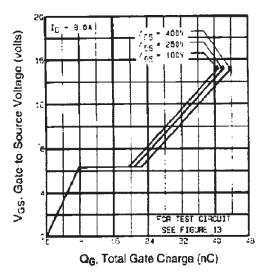


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

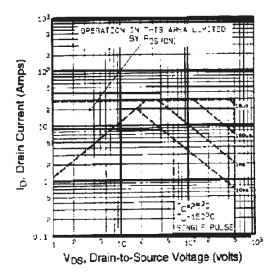


Fig. 8 - Maximum Safe Operating Area

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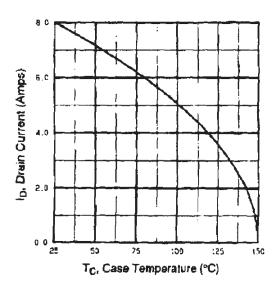


Fig. 9 - Maximum Drain Current vs. Case Temperature

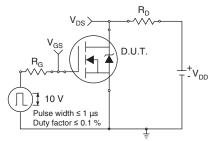


Fig. 10a - Switching Time Test Circuit

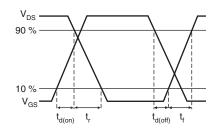


Fig. 10b - Switching Time Waveforms

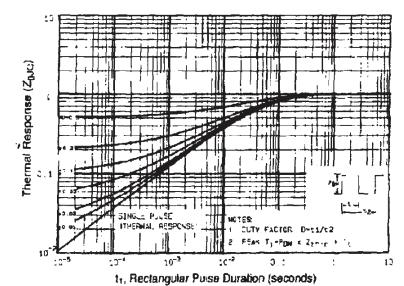


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case

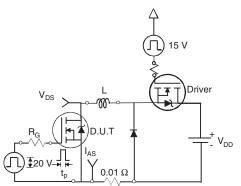


Fig. 12a - Unclamped Inductive Test Circuit

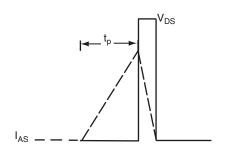


Fig. 12b - Unclamped Inductive Waveforms

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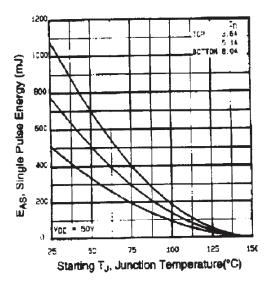


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

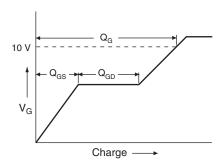


Fig. 13a - Basic Gate Charge Waveform

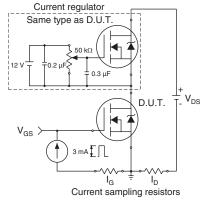
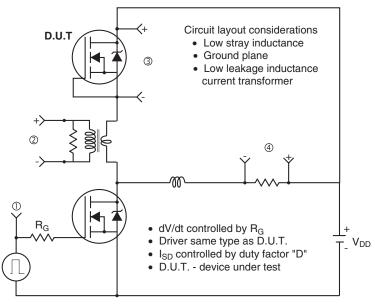
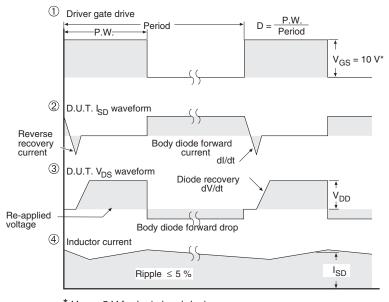


Fig. 13b - Gate Charge Test Circuit

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### Peak Diode Recovery dV/dt Test Circuit





\* V<sub>GS</sub> = 5 V for logic level devices

Fig. 14 - For N-Channel

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